

DESCRIPTION

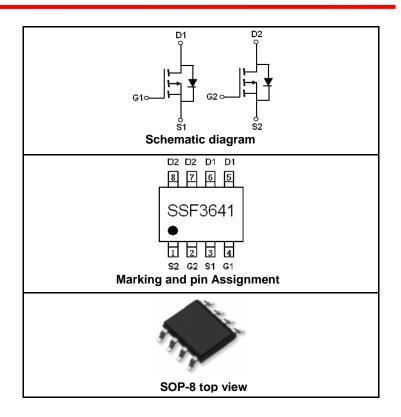
The SSF3641 uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$ and low gate charge .This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- V_{DS} =- 30V, I_{D} =-5A $R_{DS(ON)}$ < 64mΩ @ V_{GS} =-4.5V $R_{DS(ON)}$ < 49mΩ @ V_{GS} =-10V
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- ●PWM applications
- Load switch
- Power management



PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
SSF3641	SSF3641	SOP-8	Ø330mm	12mm	2500 units

ABSOLUTE MAXIMUM RATINGS(TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-30	V
Gate-Source Voltage	Vgs	±12	V
	I _D (25℃)	-5	Α
Drain Current-Continuous@ Current-Pulsed (Note 1)	I _D (70℃)	-4.2	А
	I _{DM}	-30	Α
Maximum Power Dissipation	P _D	2.0	W
Operating Junction and Storage Temperature Range	T_J,T_STG	-55 To 150	$^{\circ}$ C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	62.5	°C/W	l
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ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-30			V



Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-24V,V _{GS} =0V -1		μA		
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±12V,V _{DS} =0V			±100	nA
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250uA	-0.7		-1.3	V
Drain-Source On-State Resistance	D	V _{GS} =-4.5V, I _D =-4A		53	64	mΩ
Diam-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-5A		41	49	mΩ
Forward Transconductance	g FS	V _{DS} =-5V,I _D =-5A				S
DYNAMIC CHARACTERISTICS (Note4)	·					
Input Capacitance	C _{lss}			950		PF
Output Capacitance	C _{oss}	V_{DS} =-15V, V_{GS} =0V, F=1.0MHz		100		PF
Reverse Transfer Capacitance	C _{rss}			75		PF
SWITCHING CHARACTERISTICS (Note 4	4)					
Turn-on Delay Time	t _{d(on)}			12		nS
Turn-on Rise Time	t _r	V_{DS} =-15V, V_{GS} =-10V, R_{GEN} =3 Ω		5		nS
Turn-Off Delay Time	$t_{d(off)}$			36		nS
Turn-Off Fall Time	t _f			11		nS
Total Gate Charge	Q_g			9		nC
Gate-Source Charge	Q _{gs}	V _{DS} =-15V,I _D =-5A,V _{GS} =-4.5V		2		nC
Gate-Drain Charge	Q_{gd}			3		nC
DRAIN-SOURCE DIODE CHARACTERIST	rics	•	ı			
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-1A		-0.75	-1	V
		1				·

NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature.
 Surface Mounted on 1in² FR4 Board, t ≤ 10 sec.
 Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.

- 4. Guaranteed by design, not subject to production testing.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

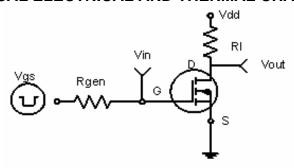


Figure 1: Switching Test Circuit

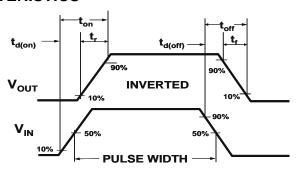


Figure 2:Switching Waveforms

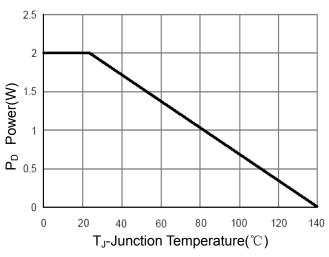


Figure 3 Power Dissipation

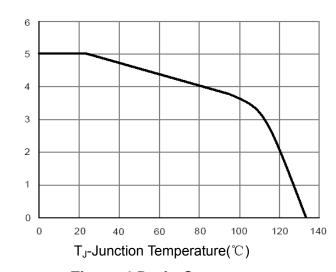


Figure 4 Drain Current

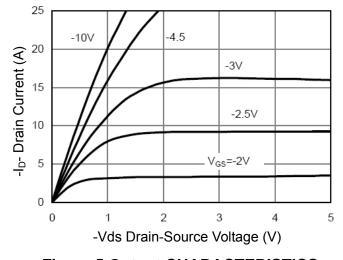


Figure 5 Output CHARACTERISTICS

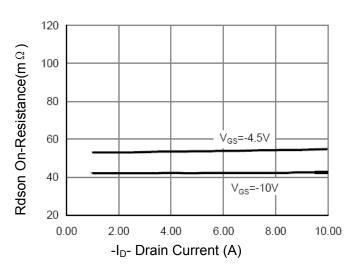


Figure 6 Drain-Source On-Resistance

-I_D- Drain Current (A)



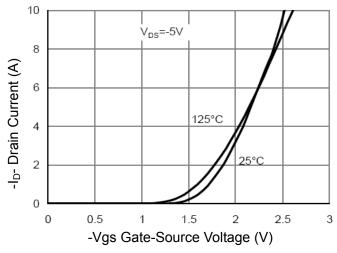


Figure 7 Transfer Characteristics

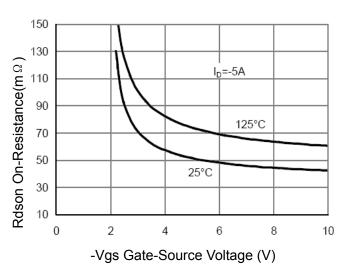


Figure 9 Rdson vs Vgs

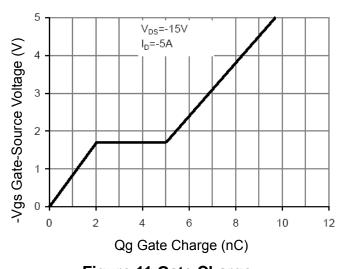


Figure 11 Gate Charge

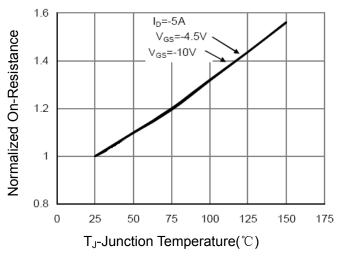


Figure 8 Drain-Source On-Resistance

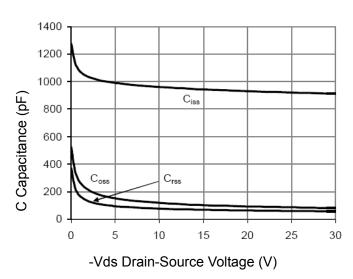


Figure 10 Capacitance vs Vds

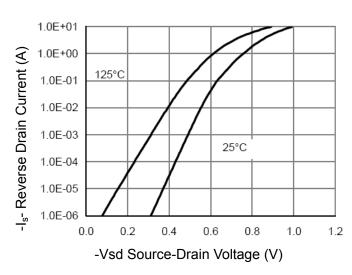


Figure 12 Source- Drain Diode Forward



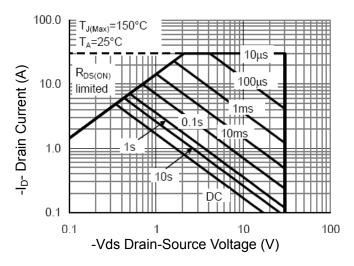
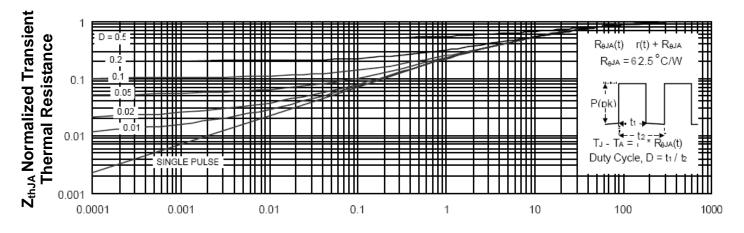


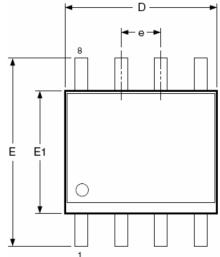
Figure 13 Safe Operation Area

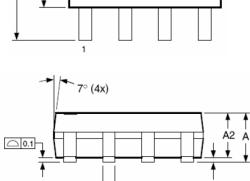


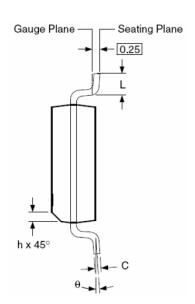
Square Wave Pluse Duration(sec)
Figure 14 Normalized Maximum Transient Thermal Impedance



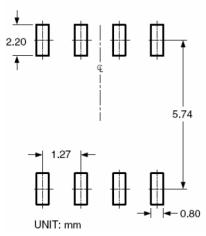
SOP-8 PACKAGE INFORMATION







RECOMMENDED LAND PATTERN



Dilliononono in miniminotoro							
Symbols	Min.	Nom.	Max.				
Α	1.35	1.65	1.75				
A1	0.10	_	0.25				
A2	1.25	1.50	1.65				
b	0.31	_	0.51				
С	0.17	_	0.25				
D	4.80	4.90	5.00				
E1	3.80	3.90	4.00				
е	1.27 BSC						
E	5.80	6.00	6.20				
h	0.25	_	0.50				
L	0.40	_	1.27				
θ	0°	_	8°				

Dimensions in millimeters

Dimensions in inches						
Symbols	Min.	Nom.	Max.			
Α	0.053	0.065	0.069			
A1	0.004	_	0.010			
A2	0.049	0.059	0.065			
b	0.012	_	0.020			
С	0.007	_	0.010			
D	0.189	0.193	0.197			
E1	0.150	0.154	0.157			
е	0	.050 BS	С			
E	0.228	0.236	0.244			
h	0.010	_	0.020			
L	0.016	_	0.050			
θ	0 °	_	8°			

NOTES:

- Dimensions are inclusive of plating
 Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
- 3. Dimension L is measured in gauge plane.
- 4. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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